

## Notice of References Cited

Applicant/Patent  
J. Alwan, et al.

Application/Control No.  
09/910,542

Examiner

Michael Day

Art Unit

2879

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### U.S. PATENT DOCUMENTS

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification<sup>2</sup></b>	
A	5,585,301	12/1996	Lee et al.	315	169.1
B					
C					
D					
E					
F					
G					
H					
I					
J					
K					
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M					

### FOREIGN PATENT DOCUMENTS

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N					
O					
P					
Q					
R					
S					
T					

### NON-PATENT DOCUMENTS

	<b>Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages</b>
U	J. Kanicki, Amorphous and Microcrystalline Semiconductor Devices: Optoelectronic Devices, 1991 (no month), pp 119-123.
V	
W	
X	

<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).      <sup>2</sup> Dates in MM-YYYY format are publication dates.      <sup>2</sup> Classifications may be U.S. or foreign.